


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/655,239	TOBITA ET AL.	
	Examiner	Art Unit	
	Long Pham	2814	

SEARCHED			
Class	Subclass	Date	Examiner
156	272.4,275.4	2/22/2005	LP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
156	272.4	2/22/2005	LP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text searches	2/22/2005	LP